

# SEMITRANS® 3

#### Trench IGBT Modules

#### SKM300GB07E3

#### Features\*

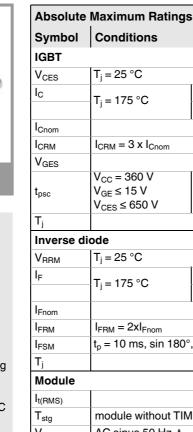
- V<sub>CE(sat)</sub> with positive temperature coefficient
- · High short circuit capability, self limiting to 6 x Icnom
- Fast & soft inverse CAL diodes
- Insulated copper baseplate using DBC Technology (Direct Copper Bonding)
- · With integrated gate resistor

#### **Typical Applications**

- · AC inverter drives
- UPS

#### Remarks

- · Case temperature limited to  $T_c = 125^{\circ}C$  max.
- Recommended T<sub>op</sub> = -40 ... +150°C
- · Product reliability results valid for  $T_i = 150$ °C
- · Use of soft R<sub>G</sub> necessary



Conditions

 $T_j = 25 \,^{\circ}C$ 

 $T_i = 175$  °C

 $I_{CRM} = 3 \times I_{Cnom}$ 

 $V_{CC} = 360 \text{ V}$ 

 $V_{GE} \le 15 \text{ V}$ 

 $T_j = 25 \,^{\circ}C$ 

 $T_j = 175$  °C

 $I_{\text{FRM}} = 2xI_{\text{Fnom}}$ 

 $t_p = 10 \text{ ms}, \sin 180^{\circ}, T_i = 25 ^{\circ}\text{C}$ 

 $V_{CES} \le 650 \text{ V}$ 

T<sub>c</sub> = 25 °C

 $T_c = 80 \, ^{\circ}C$ 

T<sub>i</sub> = 150 °C

 $T_c = 25 \,^{\circ}C$ 

 $T_c = 80 \, ^{\circ}C$ 

$I_{t(RMS)}$	module without TIM  AC sinus 50 Hz, t = 1 min			°C V		
T <sub>stg</sub>						
V <sub>isol</sub>						
			<u> </u>			
Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
IGBT	•					
V <sub>CE(sat)</sub>	$I_C = 300 \text{ A}$	T <sub>j</sub> = 25 °C		1.45	1.90	V
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		1.69	2.10	V
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.90	1.00	V
		T <sub>j</sub> = 150 °C		0.82	0.90	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 25 °C		1.83	3.0	mΩ
		T <sub>j</sub> = 150 °C		2.9	4.0	mΩ
$V_{GE(th)}$	$V_{GE}=V_{CE}$ , $I_{C}=4.8$ mA		5.1	5.8	6.4	V
I <sub>CES</sub>	$V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}, T_j = 25 ^{\circ}\text{C}$				0.3	mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		18.5		nF
C <sub>oes</sub>		f = 1 MHz		1.16		nF
C <sub>res</sub>		f = 1 MHz		0.55		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V+ 15 V			2400		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			1.0		Ω
t <sub>d(on)</sub>	$V_{CC} = 300 \text{ V}$	T <sub>j</sub> = 150 °C		157		ns
t <sub>r</sub>	$I_{C} = 300 \text{ A}$ $V_{GE} = +15/-7.5 \text{ V}$ $R_{G \text{ on}} = 2 \Omega$ $R_{G \text{ off}} = 5.6 \Omega$	T <sub>j</sub> = 150 °C		58		ns
E <sub>on</sub>		T <sub>j</sub> = 150 °C		4.7		mJ
t <sub>d(off)</sub>		T <sub>j</sub> = 150 °C		813		ns
t <sub>f</sub>	di/dt <sub>on</sub> = 6100 A/μs	T <sub>j</sub> = 150 °C		67		ns
E <sub>off</sub>	$\begin{array}{l} \text{di/dt}_{\text{off}} = 4500 \text{ A/}\mu\text{s} \\ \text{dv/dt} = 1700 \text{ V/}\mu\text{s} \\ \text{L}_{\text{s}} = 22 \text{ nH} \end{array}$	T <sub>j</sub> = 150 °C		13.6		mJ
R <sub>th(j-c)</sub>	per IGBT				0.15	K/W
R <sub>th(c-s)</sub>	per IGBT (λ <sub>grease</sub> =0.81 W/(m*K))			0.042		K/W
R <sub>th(c-s)</sub>	per IGBT, pre-applied phase change			0.038		K/W

**Values** 

650

394

297

300

900

-20 ... 20

6

-40 ... 175

650

335

244

300

600

2160

-40 ... 175

500

Unit

٧

Α

Α

Α

Α

٧

μs

°C

٧

Α

Α

Α

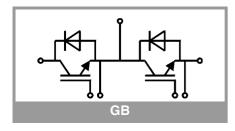
Α

Α

°C

K/W

0.038



material

 $R_{th(c\text{-}s)}$ 



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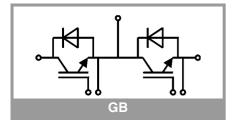
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Characteristics										
Symbol	Conditions	min.	typ.	max.	Unit					
Inverse diode										
$V_F = V_{EC}$	$I_F = 300 \text{ A}$ $V_{GE} = 0 \text{ V}$ chiplevel	T <sub>j</sub> = 25 °C		1.40	1.76	V				
		T <sub>j</sub> = 150 °C		1.39	1.77	V				
$V_{F0}$	chiplevel	T <sub>j</sub> = 25 °C		1.04	1.24	V				
Criipi	Chipievei	T <sub>j</sub> = 150 °C		0.85	0.99	V				
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.19	1.76	mΩ				
		T <sub>j</sub> = 150 °C		1.79	2.6	mΩ				
I <sub>RRM</sub>	$I_F = 300 \text{ A}$ $di/dt_{off} = 5400 \text{ A/}\mu\text{s}$ $V_{GE} = +15 \text{ /-}7.5 \text{ V}$ $V_{CC} = 300 \text{ V}$	T <sub>j</sub> = 150 °C		313		Α				
$Q_{rr}$		T <sub>j</sub> = 150 °C		31.5		μC				
E <sub>rr</sub>		T <sub>j</sub> = 150 °C		6.4		mJ				
R <sub>th(j-c)</sub>	per diode			0.25	K/W					
R <sub>th(c-s)</sub>	per diode (λ <sub>grease</sub> =0.81 W/(m*K))			0.044		K/W				
R <sub>th(c-s)</sub>	per diode, pre-applied phase change material			0.041		K/W				
Module										
L <sub>CE</sub>				15		nH				
	measured per	T <sub>C</sub> = 25 °C		0.55		mΩ				
	switch	T <sub>C</sub> = 125 °C		0.85		mΩ				
$R_{th(c-s)1}$	calculated without thermal coupling			0.01074		K/W				
R <sub>th(c-s)2</sub>	including thermal coupling, Ts underneath module (λ <sub>grease</sub> =0.81 W/(m*K))			0.018		K/W				
R <sub>th(c-s)2</sub>	including thermal coupling, Ts underneath module, pre-applied phase change material			0.016		K/W				
$M_s$	to heat sink M6		3		5	Nm				
Mt		to terminals M6	2.5		5	Nm				
						Nm				
W					325	g				



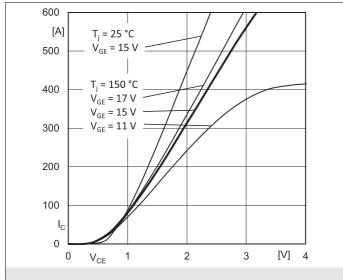


Fig. 1: Typ. output characteristic, inclusive R<sub>CC'+ EE'</sub>

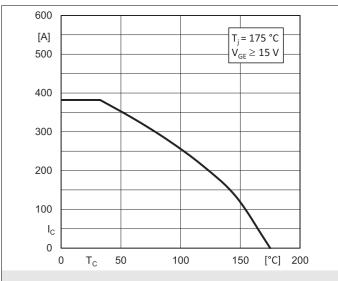


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$ 

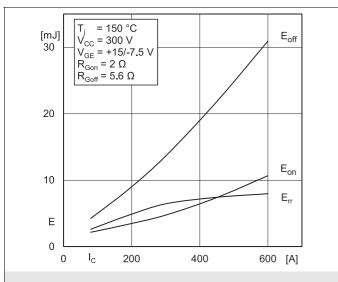


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$ 

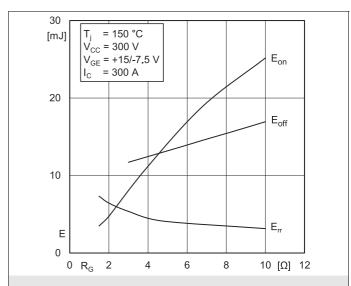


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$ 

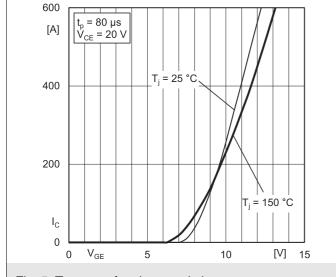


Fig. 5: Typ. transfer characteristic

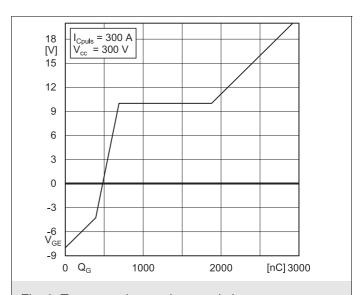


Fig. 6: Typ. gate charge characteristic

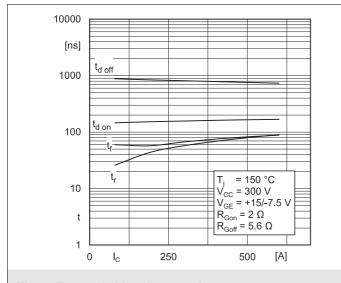


Fig. 7: Typ. switching times vs.  $I_C$ 

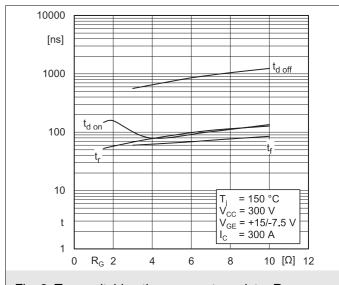


Fig. 8: Typ. switching times vs. gate resistor R<sub>G</sub>

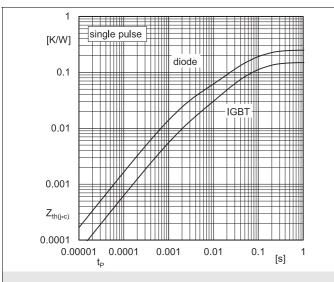


Fig. 9: Transient thermal impedance

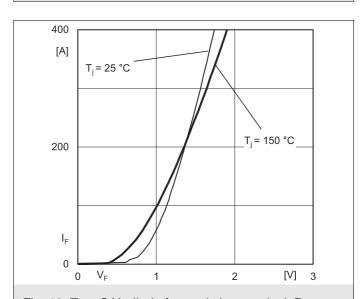


Fig. 10: Typ. CAL diode forward charact., incl. R<sub>CC'+ EE'</sub>

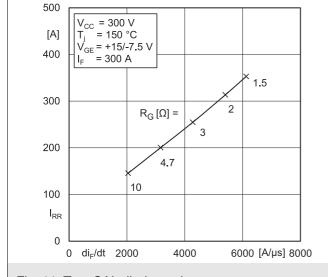


Fig. 11: Typ. CAL diode peak reverse recovery current

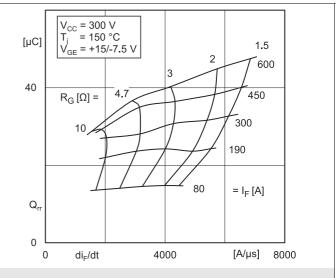
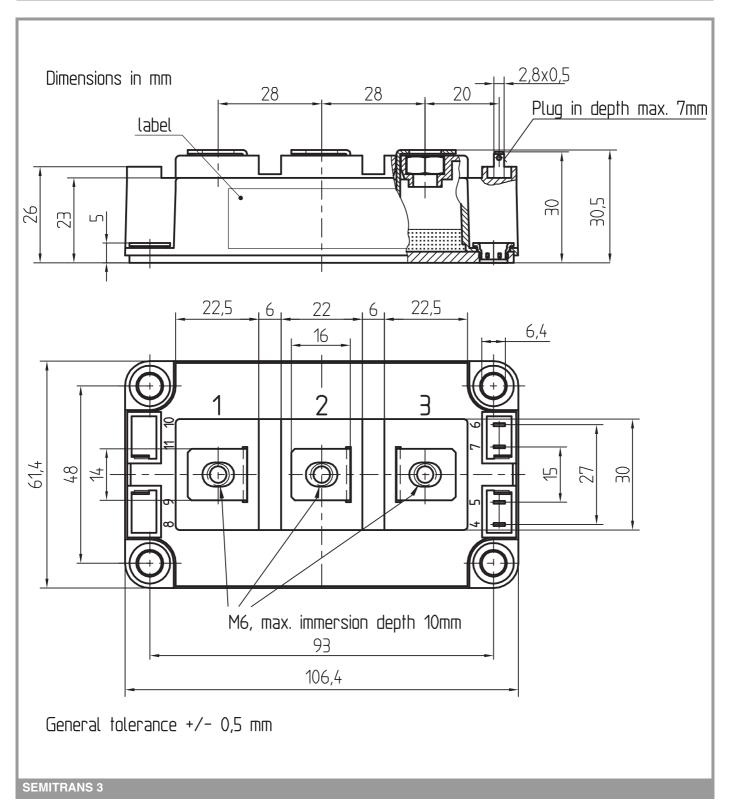
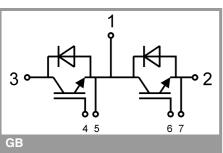


Fig. 12: Typ. CAL diode peak reverse recovery charge





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

#### \*IMPORTANT INFORMATION AND WARNINGS

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